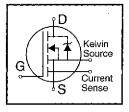
International

HEXFET[®] Power MOSFET

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Current Sense
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements

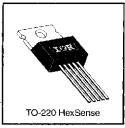


$V_{DSS} = 250V$ $R_{DS(on)} = 0.45\Omega$ $I_D = 8.1A$

Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The HEXSense device provides an accurate fraction of the drain current through the additional two leads to be used for control or protection of the device. These devices exhibit similar electrical and thermal characteristics as their IRF-series equivalent part numbers. The provision of a kelvin source connection effectively eliminates problems of common source inductance when the HEXSense is used as a fast, high-current switch in non current sensing applications.



STEE HS

Absolute Maximum Ratings

	Parameter	Max.	Units	
) @ T _C ≈ 25°C Continuous Drain Current, V _{GS} @ 10 V		8.1		
lo @ Tc = 100°C	Continuous Drain Current, VGs @ 10 V	5.1	А	
łом	Pulsed Drain Current ①	32		
Po @ Tc = 25°C	Power Dissipation	74	W	
	Linear Derating Factor	0.59	W/ºC	
Vas	Gate-to-Source Voltage	+20	V	
E _{AS}	Single Pulse Avalanche Energy ②	130	· mJ	
IAR	Avalanche Current ①	8.1	A	
EAR	Repetitive Avalanche Energy ①	7.4	mJ	
dv/dt	Peak Diode Recovery dv/dt ③	4.8	V/ns	
TJ	Operating Junction and	-55 to +150		
TSTG	Storage Temperature Range		°C	
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)		
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1 N•m)		

Thermal Resistance

	Parameter	Min.	Тур.	Max.	Units
Reac	Junction-to-Case	·	_	1.7	
Recs	Case-to-Sink, Flat, Greased Surface	—	0.50	-	°C/W
Rela	Junction-to-Ambient	—	—	62	

Document Number: 90033

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
V(BR)DSS	Drain-to-Source Breakdown Voltage	250			V	V _{GS} =0V, I _D = 250µА
ΔV _{(BR)DSS} /AT	J Breakdown Voltage Temp. Coefficient		0.37	!	V/°C	Reference to 25°C, Ip= 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance	_	—	0.45	Ω	V _{GS} =10V, 1 _D =4.9A ④
V _{GS(th)}	Gate Threshold Voltage	2.0	_	4.0	V	Vps=Vgs, Ip= 250µA
g is	Forward Transconductance	3.4	_	_	S	V _{DS} =50V, I _D =4.9A ④
IDSS	Drain to Source Laskage Current		-	25		V _{DS} =250V, V _{GS} =0V
1055	Drain-to-Source Leakage Current		_	250	μA	V _{DS} =200V, V _{GS} =0V, T _J =125°C
lass	Gate-to-Source Forward Leakage		i —	100	nA	V _{GS} =20V
Juss	Gate-to-Source Reverse Leakage	_		-100		V _{GS} =-20V
Qg	Total Gate Charge		—	41		I _D =5.6A
Qgs	Gate-to-Source Charge	_		6.5	nC	V _{DS} =200V
Q _{gd}	Gate-to-Drain ("Miller") Charge		_	22	1	V _{GS} =10V See Fig. 6 and 13 ④
t _{d(an)}	Turn-On Delay Time		9.6	—		V _{DD} =125V
tr	Rise Time	-	21		ns	Ip=5.6A
t _{ei(cíí)}	Turn-Off Delay Time		42		115	R _G =12Ω
tr.	Fall Time		19			$R_0=22\Omega$ See Figure 10 @
Lo	Internal Drain Inductance	_	4.5	—	nH	Between lead, 6 mm (0.25in.)
Ls	Internal Source Inductance	-	7.5	[from package and center of die contact
Ciss	Input Capacitance	—	770	_		V _{GS} =0V
Coss	Output Capacitance		190	-	рF	V _{DS} =25V
Crss	Reverse Transfer Capacitance	_	52			<i>f=</i> 1.0MHz_See Figure 5
r	Current Sensing Ratio	1430	_	1580		Ip=8.1A, Vgs=10V

Electrical Characteristics @ TJ = 25°C (unless otherwise specified)

Source-Drain Ratings and Characteristics

Output Capacitance of Sensing Cells

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
ls	Continuous Source Current (Body Diode)		-	8.1		MOSFET symbol showing the
t _{sm}	Pulsed Source Current → (Body Diode) ①		_	32	A	p-n junction diode.
Vsp	Diode Forward Voltage	-		2.0	۷	© V @∋±25°C, Is=8.1A, VGs
tr	Reverse Recovery Time	-	220	440	ns	Tj≃25°C, I⊧≕5.6A
Qrr	Reverse Recovery Charge		1.2	2.4	μC	di/dt≕100A/µs ⊛
ton	Forward Turn-On Time	Intrinsi	Intrinsic turn-on time is neglegible (turn-on is dominated by $L_{S}+L_{D}$)			

9.0

pF

¹ V_{GS}=0V, V_{DS}= 25V, f=1.0MHz

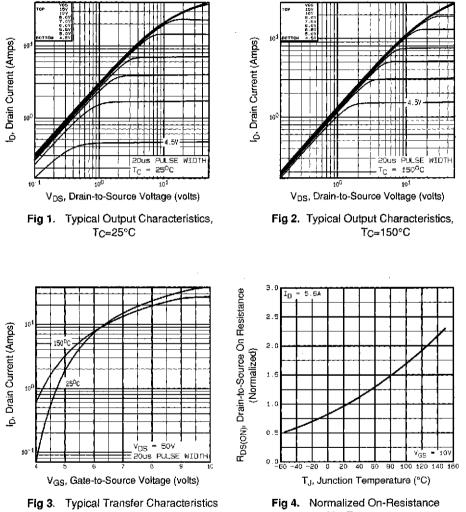
Notes:

Coss

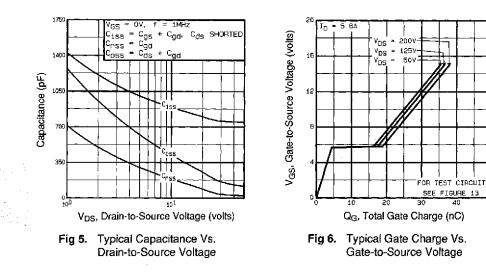
① Repetitive rating; pulse width limited by max, junction temperature (See Figure 11) ③ Isp≤8.1A, di/dt≤120A/µs, Vbp≤V(BR)bss, TJ≤150°C

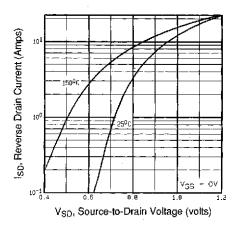
- ② V_{DD}=50V, starting T_J=25°C, L=3.2mH R_G=25Ω, I_{AS}=8.1A (See Figure 12)
- ④ Pulse width \leq 300 μ s; duty cycle \leq 2%,

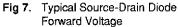
DATA Sheets

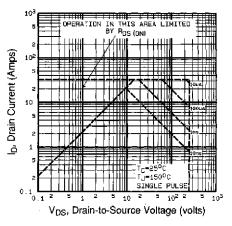


50

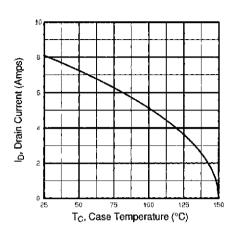




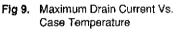








INR.



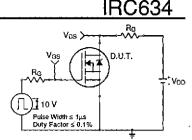


Fig 10a. Switching Time Test Circuit

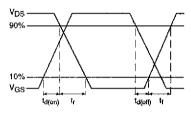
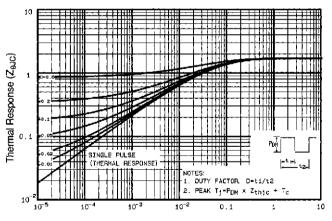
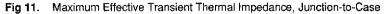


Fig 10b. Switching Time Waveforms



t₁, Rectangular Pulse Duration (seconds)



IRC634

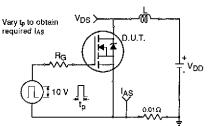


Fig 12a. Unclamped Inductive Test Circuit

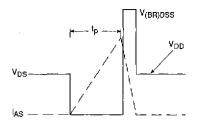


Fig 12b. Unclamped Inductive Waveforms

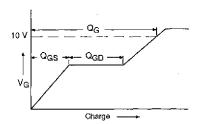


Fig 13a. Basic Gate Charge Waveform

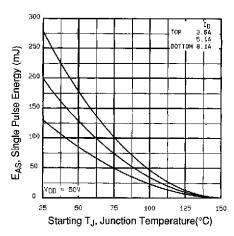


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

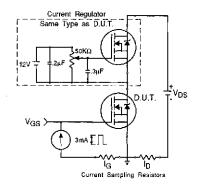


Fig 13b. Gate Charge Test Circuit

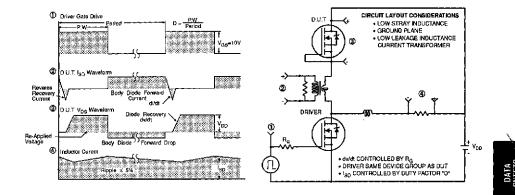
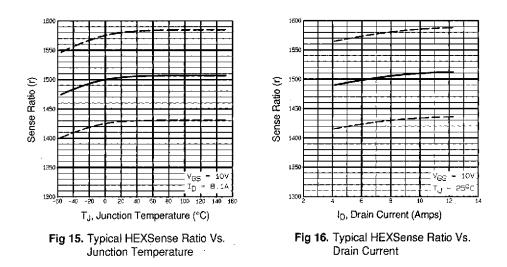
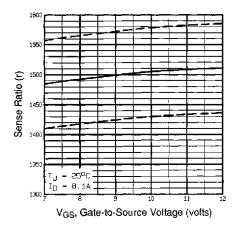
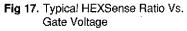
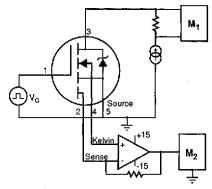


Fig 14. Peak Diode Recovery dv/dt Test Circuit

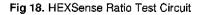








M1, M2 = HIGH SPEED DIGITAL VOLTMETERS



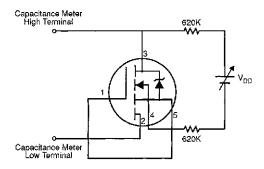


Fig 19. HEXSense Sensing Cell Output Capacitance Test Circuit

Appendix B: Package Outline Mechanical Drawing - See page 1510

Appendix C: Part Marking Information – See page 1517





Vishay

Notice

The products described herein were acquired by Vishay Intertechnology, Inc., as part of its acquisition of International Rectifier's Power Control Systems (PCS) business, which closed in April 2007. Specifications of the products displayed herein are pending review by Vishay and are subject to the terms and conditions shown below.

Specifications of the products displayed herein are subject to change without notice. Vishay Intertechnology, Inc., or anyone on its behalf, assumes no responsibility or liability for any errors or inaccuracies.

Information contained herein is intended to provide a product description only. No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document. Except as provided in Vishay's terms and conditions of sale for such products, Vishay assumes no liability whatsoever, and disclaims any express or implied warranty, relating to sale and/or use of Vishay products including liability or warranties relating to fitness for a particular purpose, merchantability, or infringement of any patent, copyright, or other intellectual property right.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications. Customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Vishay for any damages resulting from such improper use or sale.

International Rectifier[®], IR[®], the IR logo, HEXFET[®], HEXSense[®], HEXDIP[®], DOL[®], INTERO[®], and POWIRTRAIN[®] are registered trademarks of International Rectifier Corporation in the U.S. and other countries. All other product names noted herein may be trademarks of their respective owners.